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TOSHIBA CORPORATION

Semiconductor Company

Document Change Notification

The purpose of this notification is to inform customers about the launch of the Pb free version of the device. The introduction of a Pb-free replacement affects the datasheet. Please understand that this notification is intended as a temporary substitute for a revision of the datasheet.

Changes to the datasheet may include the following, though not all of them may apply to this particular device.

- 1. Part number
 - Example: TMPxxxxxF TMPxxxxxFG

All references to the previous part number were left unchanged in body text. The new part number is indicated on the prelims pages (cover page and this notification).

2. Package code and package dimensions

Example: LQFP100-P-1414-0.50C LQFP100-P-1414-0.50F

All references to the previous package code and package dimensions were left unchanged in body text. The new ones are indicated on the prelims pages.

3. Addition of notes on lead solderability

Now that the device is Pb free, notes on lead solderability have been added.

4. RESTRICTIONS ON PRODUCT USE

The previous (obsolete) provision might be left unchanged on page 1 of body text. A new replacement is included on the next page.

5. Publication date of the datasheet

The publication date at the lower right corner of the prelims pages applies to the new device.

1. Part number

2. Package code and dimensions

Previous Part Number (in Body Text)	Previous Package Code (in Body Text)	New Part Number	New Package Code	OTP
TMP87PP21F	P-QFP80-1420-0.80B	TMP87PP21FG	QFP80 ₇ P-1420-0.80B	—
TMP87PP21DF	P-LQFP80-1212-0.50A	TMP87PP21DFG	LQFP80-P-1212-0.50E	_

*: For the dimensions of the new package, see the attached Package Dimensions diagram.

3. Addition of notes on lead solderability

The following solderability test is conducted on the new device.

Lead solderability of Pb-free devices (with the G suffix)

Test	Test Conditions	Remark
Solderability	 (1) Use of Lead (Pb) solder bath temperature = 230°C dipping time = 5 seconds the number of times = once use of R-type flux (2) Use of Lead (Pb)-Free solder bath temperature = 245°C dipping time = 5 seconds the number of times = once use of R-type flux 	Leads with over 95% solder coverage till lead forming are acceptable.

4. RESTRICTIONS ON PRODUCT USE

The following replaces the "RESTRICTIONS ON PRODUCT USE" on page 1 of body text.

RESTRICTIONS ON PRODUCT USE

• The information contained herein is subject to change without notice.

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- In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
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- For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.

5. Publication date of the datasheet

The publication date of this datasheet is printed at the lower right corner of this notification.

(Annex)

Package Dimensions

LQFP80-P-1212-0.50E



(Annex)

Package Dimensions

QFP80-P-1420-0.80B



CMOS 8-Bit Microcontroller

TMP87PP21F TMP87PP21DF

The TMP87PP21 is a One-Time PROM microcontroller with low-power 48 K × 8 bits electrically programmable read only memory for the TMP87CH21C/M21C/P21C system evaluation. The TMP87PP21/ is pin compatible with the TMP87CH21C/M21C/P21C. The operations possible with the TMP87CH21C/M21C/P21C can be performed by writing programs to PROM. The TMP87PP21 can write and verify in the same way as the TC571000D using an adaptor socket BM11104/BM11105 and an EPROM programmer.



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- For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.
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Pin Assignments (Top View)







Pin Functions

The TMP87PP21 has two modes: MCU and PROM.

(1) MCU mode

In this mode, the TMP87PP21 is pin compatible with the TMP87CH21C/M21C/P21C (fix the TEST pin at low level.)

(2) PROM mode

Pin Name (PROM mode)	Input/Output	Functions	Pin Name (MCU mode)
A16			P60
A15 to A8	Input	PROM address inputs	P77 to P70
A7 to A0			SEG8 to 11, P93 to P90
D7 to D0		PROM data input/outputs	SEGO to SEG7
CE		Chip enable signal input (active low)	P13
<u> </u>	Input	Output enable signal input (active low)	P14
PGM		Program mode signal input)) P15
VPP		+ 12.75 V/5 V (Program supply voltage)	TEST
vcc	Power supply	+ 6.25 V/5 V	VDD
GND		() V	VSS
P37 to P32, P30	(
P47 to P40			
P57 to P50		Pull-up with resistance for input processing.	
P67 to P62	()		
P11		\sim (7/5)	
P21			
P31		PROM mode setting pin. Be fixed at high level.	
P61			
P17, P16, P12, P10 P22, P20	\mathcal{D}	>	
RESET	$\langle \langle \rangle$	PROM mode setting pin. Be fixed at low level.	
XIN	Input		
XQUT	Output	Connect an 8 MHz oscillator to stabilize the internal s	tate.
VAREF			
VASS	Power supply	0 V (GND)	
COM3 to COM0	Output		
VLC	LCD driver Power supply	Open	

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Operational Description

The following explains the TMP87PP21 hardware configuration and operation. The configuration and functions of the TMP87PP21 are the same as those of the TMP87CH21C/M21C/P21C, except in that a one-time PROM is used instead of an on-chip mask ROM.

The TMP87PP21 is placed in the *single-clock* mode during reset. To use the dual-clock mode, the low-frequency oscillator should be turned on by executing [SET (SYSCR2). XTEN] instruction at the beginning of the program.

1. Operating Mode

The TMP87PP21 has two modes: MCU and PROM.

1.1 MCU mode

The MCU mode is activated by fixing the TEST/VPP pin at low level. In the MCU mode, operation is the same as with the TMP87CH21C/M21C/P21C (the TEST/VPP pin cannot be used open because it has no built-in pull-down resistance)

1.1.1 Program Memory

The TMP87PP21 has a $48K \times 8$ bits (addresses 4000_H to FFFF_H in the MCU mode, addresses 14000_H to 1FFFF_H in the PROM mode) of program memory (OTP).

When the TMP87PP21 is used as a system evaluation of the TMP87CH21C/M21C/R21C, the data is written to the program storage area shown in Figure 1-1.



1.1.2 Data Memory

The TMP87PP21 has an on-chip 2 K \times 8 bits data memory (static RAM).

1.1.3 Input/Output Circuitry

(1) Control pins

The control pins of the TMP87PP21 are the same as those of the TMP87CH21C/M21C/P21C except that the TEST pin has no built-in pull-down resistance.

1 kΩ (typ.)
7777
Figure 1-2. TEST pin
(2) I/O ports
The I/O circuitries of the TMP87PP21 I/O ports are the same as circuitries of the TMP87CH21C/M21C/P21C.
$(\frown \frown)$
/
\rightarrow

1.2 PROM Mode

The PROM mode is activated by setting the TEST, RESET pin and the ports P17 to P10, P22 to P20 and P31, P61 as shown in Figure 1-3. The PROM mode is used to write and verify programs with a general-purpose PROM programmer.

Note: The high-speed programming mode can be used for program operation. (P)ease set the highspeed programming mode according to each manual of PROM programmer.) The TMP87PP21 is not supported an electric signature mode, so the ROM type must be set to TC571000D.



1.2.1 Programming Flowchart (High-speed Programming Mode)

The high-speed programming mode is achieved by applying the program voltage (+ 12.75 V) to the VPP pin when Vcc = 6.25 V. After the address and input data are stable, the data is programmed by applying a single 0.1ms program pulse to the PGM input. The programmed data is verified. If incorrect, another 0.1 ms program pulse is applied. This process should be repeated (up to 25 times) until the program operates correctly. After that, change the address and input data, and program as before. When programming has been completed, the data in all addresses should be verified with Vcc = Vpp = 5 V.



1.2.2 Writing Method for General-purpose PROM Program

- (1) Adapters BM11104: TMP87PP21F BM11105: TMP87PP21DF
- (2) Adapter setting Switch (SW1) is set to side N.
- (3) PROM programmer specifying
 - i) PROM type is specified to TC571000D. Writing voltage: 12.75 V (high-speed program mode)
 - ii) Data transfer (copy) (Note 1)

In the TMP87PP21, EPROM is within the addresses 14000_H to 1FFFF_H. Data is required to be transferred (copied) to the addresses where it is possible to write. The program area in MCU mode and PROM mode is referred to "Program memory area" in Figure 1-1.

Ex. In the block transfer (copy) mode, executed as below. ROM capacity of 48 KB: transferred addresses 04000_H to 0FFFF_H to addresses 14000 to 1FFFF_H

iii) Writing address is specified. (Note 1) Start address: 14000_H End address: 1FFF_H

(4) Writing

Writing/Verifying is required to be executed in accordance with PROM programmer operating procedure.

- Note 1: The specifying method is referred to the **PROM** programmer description. Either write the data FF_H to the unused area or set the **PROM** programmer to access only the program storage area.
- Note 2: When MCU is set to an adapter or the adapter is set to PROM programmer, a position of pin 1 must be adjusted. If the setting is reversed, MCU, the adapter and PROM program is damaged.
- Note 3: The TMP87PP21 does not support the electric signature mode (hereinafter referred to as "signature"). If the signature is used in PROM program, a device is damaged due to applying $12 V \pm 0.5 V$ to the address pin 9 (A9). The signature must not be used.

Electrical Characteristics

Absolute Maximum Rat	tings	(V _{SS} = 0 V)		
Parameter	Symbol	Pins	Ratings	Unit
Supply Voltage	V _{DD}		-0.3 to 6.5	
Program Voltage	V _{PP}	TEST/V _{PP}	– 0.3 to 13.0	.,
Input Voltage	V _{IN}		-0.3 to V _{DD} + 0.3	V
Output Voltage	V _{OUT}		– 0.3 to V _{DD} + 0.3	
Output Current (Per 1 pin)	I _{OUT1}	Ports P0, P1, P2, P3, P5, P6, P7, P8, P9, P4 (except P41)	3.2	
	I _{OUT2}	P41	30	
Output Current (Total)	Σ I _{OUT1}	Ports P0, P1, P2, P3, P5, P6, P7, P8, P9, P4 (except P41)	120	mA
	ΣI_{OUT2}	P41	()30	
Power Dissipation [Topr = 70°C]	PD		350	mW
Soldering Temperature (time)	Tsld		260 (10 s)	
Storage Temperature	Tstg		– 55 to 125	°C
Operating Temperature	Topr		- 30 to 70	

Note: The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

Recommended Operating Conditions $(V_{SS} = 0 V, Topr = -30 \text{ to } 70^{\circ}\text{C})$

Parameter	Symbol	Pins	Conditions	Min	Max	Unit
			fc = 8 MHz NORMAL1, 2 mode	- 4.5		
Supply Voltage		$(\sqrt{2})$	fc = 4.2 MHz			
	/ Y _{DD}		IDLE1, 2 mode	2.7	5.5	
			fs = SLOW mode	2.7		
			32.768 kHz SLEEP mode			
			STOP mode	2.0		
\sim	V _{IH1}	Except hysteresis input	V _{DD} ≧4.5 V	$V_{DD} \times 0.70$		
Input High Voltage	V _{IH2}	Hysteresis input	V _{DD} ≡ 4.5 V	$V_{DD} \times 0.75$	V _{DD}	
	V _{IH3}		V _{DD} <4.5 V	V _{DD} × 0.90		
\sim (()	V _{IL1}	Except hysteresis input	V _{DD} ≧4.5 V		$V_{DD} \times 0.30$	
Input Low Voltage	V _{IL2}	Hysteresis input	V _{DD} =4.3 V	0	V _{DD} × 0.25	
	V _{IL3} (($\left(\begin{array}{c} \\ \\ \\ \\ \end{array} \right)$	V _{DD} <4.5 V		V _{DD} × 0.10	
	fc	XIN, XOUT	V _{DD} = 4.5 to 5.5 V	0.4	8.0	MHz
Clock Frequency			V _{DD} = 2.7 to 5.5 V	0.4	4.2	
\sim	fs	XTIN, XTOUT		30.0	34.0	kHz

Note 1: The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

Note 2: Clock frequency fc: Supply voltage range is specified in NORMAL1/2 mode and IDLE1/2 mode.

DC Chara	cteristic	s (V _{SS} = 0 V, Topr =	= – 30 to 70°C)				
Parameter	Symbol	Pins	Conditions	Min	Тур.	Max	Unit
Hysteresis Voltage	V _{HS}	Hysteresis inputs		(-	0.9	_	V
	I _{IN1}	TEST	(\overline{a})				
Input Current	I _{IN2}	Open drain ports and tri-state ports	V _{DD} = 5.5 V, V _{IN} = 5.5 V/0 V	\mathcal{D}	_	± 2	μA
	I _{IN3}	RESET, STOP					
Input Low Current	Ι _{ΙL}	Push-pull ports	$V_{DD} = 5.5 V, V_{IN} = 0.4 V$	-	-	- 2	mA
Input Resistance	R _{IN2}	RESET		100	220	450	kΩ
Output Leakage Current	I _{LO}	Open drain ports Tri-state ports	V _{DD} = 5-5-V, V _{OUT} = 5.5 V	- (2	μΑ
Output Ulah Maltana	V _{OH1}	Push-pull ports P4 ports	$V_{DD} = 4.5 V, I_{OH} = -200 \mu A$	2.4	D)-	5-	
Output High Voltage	V _{OH2}	Tri- state ports P1, P5 ports	$V_{\rm DD} = 4.5 \text{V}, 1_{\rm OH} = -0.7 \text{mA}$	4.1	G-	7-	l v
Output Low Voltage	V _{OL}	Except XOUT and P41	ept XOUT and P41 $V_{DD} = 4.5 V$, $I_{OL} = 1.6 \text{ mA}$			0.4	
Output Low Current	I _{OL3}	P41	$V_{DD} = 4.5 V, V_{OL} = 1.0 V$	$(\overline{)}$	20	_	
Supply Current in NORMAL 1 , 2 mode			V _{DD} = 5.5 V fc = 8 MHz	2	12	18	mA
Supply Current in IDLE 1, 2 mode			fs = 32.768 kHz V _{IN} = 5/3 V/0.2 V	_	6	10	
Supply Current in SLOW mode	I _{DD}		V _{DD} = 3:0 V fs = 32.768 kHz	_	30	60	
Supply Current in SLEEP mode			V _{IN} = 2.8 V/0.2 V LCD driver is not enable	_	15	30	μA
Supply Current in STOP mode			V _{DD} =5.5 V V _{IN} =5.3 V/0.2 V	_	0.5	10	
Segment Output Low Resistance	Rost	SEG31 to SEG0			20		
Common Output Low Resistance	Roc1	COM3 to COM0	Ď		20		
Segment Output High Resistance	R _{OS2}	SEG31 to SEG0	V _{DD} = 5 V		200		kΩ
Common Output High Resistance	R _{OC2}	COM3 to COM0	$V_{DD} - V_{LC} = 3 V$		200		
	V0213	<u> </u>	1	3.8	4.0	4.2	
Segment/Common Output Voltage	V _{O 1/2}	SEG31 to SEG0 and COM3 to COM0		3.3	3.5	3.7	V
carbar rounde	V _{0 1/3}			2.8	3.0	3.2	1

Note 1: Typical values show those at Topr = 25%, $V_{DD} = 5V$.

Note 2: Input Current ; The current through pull-up or pull-down resistor is not included.

Note 3: 1_{DD}: Except for I_{REF}

Note 4: Output resistors Ros, Roc indicate "on" when switching levels.

Note 5: $V_{O2/3}$ indicates an output voltage at the 2/3 level when operating in the 1/4 or 1/3 duty mode.

Note 6: V_{01/2} indicates an output voltage at the 1/2 level when operating in the 1/2 duty or static mode.

Note 7: $V_{O1/3}$ indicates an output voltage at the 1/3 level when operating in the 1/4 or 1/3 duty mode.

Note 8: When using LCD, it is necessary to consider values of Ros1/2 and Roc1/2.

Note 9: Times for SEG/COM output switching on: Ros1, Roc1: 26/fc, 2/fs (s)

Ros2, Roc2: 1/(n, f_F)

(1/n: duty, f_F: frame frequency)

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Angles Defense of Malteria	V _{AREF}		2.7	(-)	V V _{DD}	
Analog Reference Voltage	V _{ASS}	$V_{AREF} - V_{ASS} \ge 2.5 V$	V _{SS}	$\overline{}$	1.5	v
Analog Input Voltage	V _{AIN}		VASS	(/ A	V _{AREF}	
Analog Supply Current	I _{REF}	V _{AREF} = 5.5 V, V _{ASS} = 0.0 V		0.5	1.0	mA
Nonlinearity Error		$V_{DD} = 5.0 V, V_{SS} = 0.0 V$		> -	± 1	
Zero Point Error		V _{AREF} = 5.000 V V _{ASS} = 0.000 V	$\overline{}$	_	±1	
Full Scale Error		or $V_{DD} = 2.7 V, V_{SS} = 0.0 V$	102	<	(±1)	LSB
Total Error		V _{AREF} = 2.700 V V _{ASS} = 0.000 V	>>	- 2	±2	
Note: Quantizing error is not	contained in	those errors.)) <	>	$) \bigcirc$	

D				^		
Parameter	Symbol	Conditions	Min	🔨 Тур.	Max	Unit
Machine Cycle Time		In NORMAL 1, 2 mode	0.5 -		10	
	t _{cy}	In SLOW mode	117.6	Ι	133.3	- μ s
High Level Clock Pulse Width	twch	For external clock operation				
Low Level Clock Pulse Width	twci	(XIN input), fc = 8 MHz	62.5	_	_	ns
High Level Clock Pulse Width	twsH	For external clock operation				
Low Level Clock Pulse Width	(tws/ <	(XTIN input), fs = 32 768 kHz	14.7	I	-	μS

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
		In NORMAL 1, 2 mode In IDLE 1, 2 mode	0.95	_	10	
Machine Cycle Time	t _{cy}	In SLOW mode In SLEEP mode	117.6	_	133.3	μs
High Level Clock Pulse Width Low Level Clock Pulse Width	twcн ∕twc⊾	For external clock operation (XIN input), fc = 4.2 MHz	110	_	_	ns
High Level Clock Pulse Width	twsh twsL	For external clock operation (XTIN input), fs = 32.768 kHz	14.7	_	-	μs

Recomended	Oscillating Condi	tion-1 (VSS	= 0 V, VDD = 4.5 to 5.5 V,	, Topr = – 30 to 70°C)		
Parameter	Osillator	Frequency Recommender Oscillator		er Oscillator	Recomn Cond	ition
))¢1	C ₂
Cera			KYOCERA	KBR8.0M	30 pF	30 pF
			Standard/Lead Type	CSA8.00MTZ	built-in	built-in
	Ceramic Resonator		(MURATA)	CST8.00MTW	30 pF	30 pF
		8 MHz	Standard/SMP Type (MURATA)	CSAC8.00MT	30 pF	30 pF
High-frequency			Standard/Small ChipTyp	e CSTC8.00MT	built-in	built-in
ringri-frequency			(MURATA)		30 pF	30 pF
		4 MHz	KYOCERA	KBR4.0MS	30.pF	30 pF
		8 MHz	точосом	210B 8.0000	\bigcirc	
	Crystal Oscillator	4 MHz	точосом	204B 4.0000	20 pF	20 pF
Low-frequency	Crystal Oscillator	32.768 kHz		MX-38T	15 pF	15 pF

Recomended Oscillating Condition-2 (VSS = 0V, VDD = 2.7 to 5.5V, Topr = - 30 to 70°C)

Parameter	Osillator Frequency Recommender Oscillator			mended dition C ₂		
		CA	Standard/Lead Type	CSA4.00MG	30 pF	30 pF
			(MURATA)	CST4.00MGW	built-in 30 pF	built-in 30 pF
High-frequency	Ceramic Resonator	4 MiHz	Standard/SMDType (MURATA)	CSA4.00MGC CSAC4.00MGCM	30 pF	30 pF
			$(7/ \land$	CSTC4.00MG	built-in	built-in
		\neg	$(\langle \langle \rangle \rangle)$		30 pF	30 pF
			Stondond/Cmall Chin Tuno		built-in	built-in
		Standard/Small Chip Type	C51C54.00IVIG	10 pF	10 pF	



Note1: When used in high electric field such as a picture tube, the package is recommended to be electrically shielded to maintain a regular operation. Note2: The product numbers and specifications of the resonators by Murata Manufacturing Co., Ltd. are subject to change.

ote2: The product numbers and specifications of the resonators by Murata Manufacturing Co., Ltd. are subject to change. For up-to-date information, please refer to the following URL;

http://www.murata.co.jp/search/index.html



Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Input High Voltage	V _{IH4}		V _{CC} × 0.7		V _{cc}	
Input Low Voltage	V _{IL4}		0	(-(V _{CC} × 0.12	v
Power Supply Voltage	V _{CC}		6.0	6.25	6.5	v
Program Power Supply Voltage	V _{PP}		12.5	12.75	13.0	
Initial Program Pulse Width	t _{PW}	V _{CC} = 6.0 V	0.095	0.1	0.105	ms

(2) High-Speed Programming Operation



Note1: When V_{cc} power supply is turned on or after, V_{pp} must be increased. When V_{cc} power supply is turned off or before, V_{pp} must be increased. Note2: The device must not be set to the EPROM programmer or picked op from it under applying the program voltage (12.75 V ± 0.25 V = V) to the V_{pp} pin as the device is damaged.

Note3: Be sure to execute the recommended programing mode with the recommended programing adaptor. If a mode or an adaptor except the above, the misoperation sometimes occurs.

